# onsemi

# Self Test Ground Fault Circuit Interrupter (GFCI)

# NCS37015

The NCS37015 is a UL943 compliant signal processor for GFCI applications with self test. The device integrates a flexible power supply (including a 12 V shunt and two 3.3 V internal series regulators), differential fault, and grounded-neutral detection circuits. Self test is monitored at start up and then every 17 minutes.

### Features

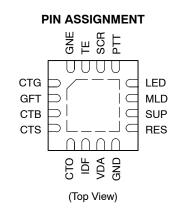
- Meets UL943 Self-test GFCI Requirements
- 4.0 12 Volt Operation (120–480 V AC mains with the appropriate series impedance)
- -40°C to 95°C
- Typical 575 µA Quiescent Current @ 11 V
- 16 Pin QFN
- Inverted and Latched SCR Output to Facilitate a Solenoid Operation
- Self Syncing Internal Oscillator adjusts to AC Mains Frequency to Guarantee Full Resolution on 60 Hz Distribution Systems
- Optimized Solenoid Deployment (coil is not energized near the AC mains zero crossings)
- Power Supply Monitor that Verifies Full Diode Bridge Operation
- Tiered Trip Times that Increase Immunity to Noise
- Under-voltage Detection that Allows for Increased Operation at Lower AC Input Voltages

#### **Typical Applications**

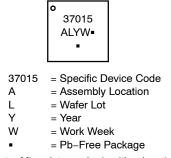
- Portable GFCI Plugs
- GFCI Receptacles



QFN16 CASE 485FQ



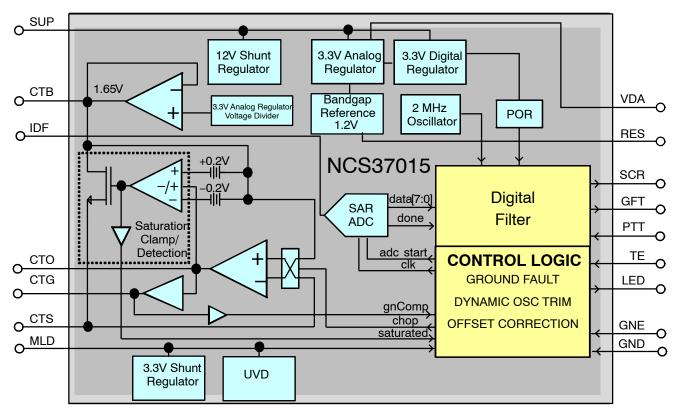
#### MARKING DIAGRAM



(Note: Microdot may be in either location)

#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 8 of this data sheet.





#### Table 1. QFN PIN DESCRIPTION

Pin #	Name	Pad Description		
1	CTG	Ground Neutral current transformer stimulus		
2	GFT	Differential self test output signal		
3	СТВ	Differential current transformer bias voltage		
4	CTS	Differential current input		
5	СТО	Differential current to voltage output		
6	IDF	Differential low pass filter/ADC input		
7	VDA	Analog 3.3 V regulator output/ ADC reference voltage		
8	GND	Electronics ground		
9	RES	Reference current bias input		
10	SUP	Power supply input		
11	MLD	Mains level/under voltage detector		
12	LED	End of life LED drive		
13	PTT	Push to test input		
14	SCR	SCR gate drive signal		
15	TE	Test enable		
16	GNE	Ground-neutral enable input		

#### Table 2. ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Supply Voltage Range	Vs	13.5	V
Supply Current	ls	10	mA
Input Voltage Range (Note 3)	V <sub>in</sub>	–0.3 to 3.6	V
Output Voltage Range	V <sub>out</sub>	–0.3 to 3.6 V or (V <sub>in</sub> + 0.3), whichever is lower	V
Maximum Junction Temperature	T <sub>J(max)</sub>	140	°C
Storage Temperature Range	TSTG	–65 to 150	°C
ESD Capability, Human Body Model (Note 4)	ESD <sub>HBM</sub>	2	kV
ESD Capability, Charge Device Model (Note 4)	ESD <sub>CDM</sub>	500	V
Lead Temperature Soldering Reflow (SMD Styles Only), Pb-Free Versions (Note 5)	T <sub>SLD</sub>	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Functional operation above the Recommended Operating Conditions is not implied. Extended

Exposure to stresses above the Recommended Operating Conditions may affect device reliability.
 Refer to ELECTRICAL CHARACTERISTICS and APPLICATION INFORMATION for Safe Operating Area.

4. This device series incorporates ESD protection and is tested by the following methods:

ESD Human Body Model tested per JS-001-2012 ESD Charge Device Model tested per JESD22-C101-F

Latchup Current Maximum Rating: ≤100 mA per JEDEC standard: JESD78D

5. For information, please refer to our Soldering and Mounting Techniques Reference Manual, SOLDERRM/D

#### **Table 3. THERMAL CHARACTERISTICS**

Rating	Symbol	Value	Unit
Thermal Characteristics, QFN16, 3x3.3 mm (Note 6) Thermal Resistance, Junction-to-Air (Note 7)	R <sub>θJA</sub>	64	°C/W

6. Refer to ELECTRICAL CHARACTERISTICS and APPLICATION INFORMATION for Safe Operating Area.

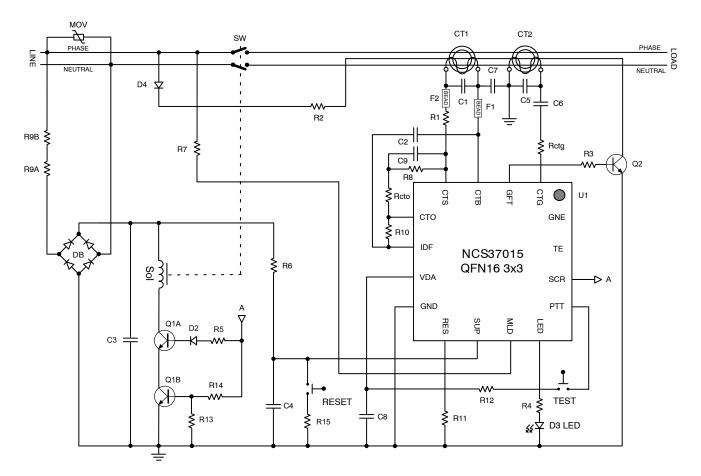
7. Values based on copper area of 645 mm<sup>2</sup> (or 1 in<sup>2</sup>) of 1 oz copper thickness and FR4 PCB substrate.

Table 4. OPERATING RANGES (Unless oth	wise noted, I <sub>SUP</sub> = 3 mA, MLD input = 60 Hz, Refer to Figure 2)
---------------------------------------	--

Periodic ST Timer, PassSteady State, ST Pass151720minuterLED Blink FrequencyFirst ST Failure1.822.2HzST Cycle GF Pass WindowIDIFF Ground Fault614mAMLD Pin Check Wait Time to Enable LEDNo MLD signal500ImsMLD Pin Continuity PassInput Frequency25HzLED Blink FrequencyNo MLD signal1.522.5	Parameter	Conditions	Min	Тур	Max	Units
Shunt Regulator Current         IsµP         Image: the symbol of the sy	Operating Temperature	Ambient	-40		95	С
Quiescent Current $I_{SUP}$ , SUP = 10.5 V         575         750 $\mu A$ RMS Trip Threshold Voltage         IDF to CTB, R8 = 32 kQ, R <sub>CTO</sub> = 500 Q         191         203         215         mV           SCR Trigger Current $I_{SCR}$ , SCR = 1 V, $I_{SHUNT} < 6 mA$	Shunt Regulator Voltage	SUP to GND, I <sub>SUP</sub> = 1 mA		12	13	V
RMS Trip Threshold Voltage         IDF to CTB, R8 = $32 \ k\Omega$ , R <sub>CTO</sub> = $500 \ \Omega$ 191         203         215         mV           SCR Trigger Current         I <sub>SCR1</sub> , SCR = 1 V, I <sub>SHUNT</sub> < 6 mA	Shunt Regulator Current	I <sub>SUP</sub>			10	mA
SCR Trigger Current         Isc.R. SCR = 1 V, IsHUNT < 6 mA         4         mA           SCR Trigger Output Voltage         SCR to GND, SUP < 4 V	Quiescent Current	I <sub>SUP</sub> , SUP = 10.5 V		575	750	μΑ
SCR Trigger Output Voltage         SCR to GND, SUP < 4 V         3	RMS Trip Threshold Voltage	IDF to CTB, R8 = 32 k $\Omega$ , R <sub>CTO</sub> = 500 $\Omega$	191	203	215	mV
LED output Voltage         LED to GND, SUP < 4 V         3         3.6         V           CTB Bias Voltage         CTB to GND, VDA = 3.3 V         1.65         V           CTS-CTB Absolute Offset Voltage         CTS-CTB         -250         250 $\mu$ V           Fault Response Time         6 mA ≤ $I_{DIFF} < 10$ mA         125         ms           Fault Response Time         10 mA ≤ $I_{DIFF} < 15$ mA         95         ms           Fault Response Time         15 mA ≤ $I_{DIFF} < 215$ mA         0         60         ms           Fault Response Time         17.5 mA ≤ $I_{DIFF} < 22.5$ mA         0         60         ms           Fault Response Time         20 mA ≤ $I_{DIFF} < 22.5$ mA         0         60         ms           Fault Response Time         20 mA ≤ $I_{DIFF} < 22.5$ mA         0         0         ms           Fault Response Time         22.5 mA ≤ $I_{DIFF} < 23.5$ mA         0         0         ms           Fault Response Time         29.0 mA ≤ $I_{DIFF} < 3.3$ mA         20         ms           Fault Response Time         10.0 F2 = 33.0         1.95         V           CTG Comparator Threshold         CTG to GND, VDA = 3.3 V         1.95         V           CTG G NTrip Frequency         CTG to GND, R = 1 MQ, ±1%	SCR Trigger Current	I <sub>SCR</sub> , SCR = 1 V, I <sub>SHUNT</sub> < 6 mA	4			mA
CTB Bias Voltage         CTB to GND, VDA = $3.3$ V         1.65         V           CTS-CTB Absolute Offset Voltage         CTS-CTB $-250$ $250$ $\mu$ V           Fault Response Time $6$ mA $\leq I_{DIFF} < 10$ mA         125         ms           Fault Response Time $10$ mA $\leq I_{DIFF} < 15$ mA         95         ms           Fault Response Time $15$ mA $\leq I_{DIFF} < 20$ mA         60         ms           Fault Response Time $20$ mA $\leq I_{DIFF} < 20$ mA         60         ms           Fault Response Time $20$ mA $\leq I_{DIFF} < 20$ mA         60         ms           Fault Response Time $20$ mA $\leq I_{DIFF} < 20$ mA         60         ms           Fault Response Time $20$ mA $\leq I_{DIFF} < 20$ mA         40         ms           Fault Response Time $22.5$ mA $\leq I_{DIFF} < 29$ mA         25         ms           Fault Response Time $29$ mA $\leq I_{DIFF} < 33$ mA         25         ms           Fault Response Time $I_{DIFF} < 33$ mA         20         ms           CTG Comparator Threshold         CTG to GND         2         7         kHz           GN Response Time         Continuous GN Fault         350         ms           Internal Oscillator Frequency <td>SCR Trigger Output Voltage</td> <td>SCR to GND, SUP &lt; 4 V</td> <td>3</td> <td></td> <td>3.6</td> <td>V</td>	SCR Trigger Output Voltage	SCR to GND, SUP < 4 V	3		3.6	V
CTS-CTB Absolute Offset Voltage         CTS-CTB         -250         250 $\mu$ V           Fault Response Time         6 mA $\leq l_{DIFF} < 10$ mA         125         ms           Fault Response Time         10 mA $\leq l_{DIFF} < 15$ mA         95         ms           Fault Response Time         15 mA $\leq l_{DIFF} < 15$ mA         10         75         ms           Fault Response Time         17.5 mA $\leq l_{DIFF} < 20$ mA         600         ms           Fault Response Time         20 mA $\leq l_{DIFF} < 22.5$ mA         50         ms           Fault Response Time         20.0 mA $\leq l_{DIFF} < 22.5$ mA         400         ms           Fault Response Time         22.5 mA $\leq l_{DIFF} < 28.5$ mA         400         ms           Fault Response Time         29.0 mA $\leq l_{DIFF} < 23.3$ mA         22.5         ms           Fault Response Time         29.0 mA $\leq l_{DIFF} < 33.3$ mA         20         ms           CTG Comparator Threshold         CTG to GND, VDA = 3.3 V         1.95         V           CTG G NTip Frequency         CTG to GND         2         7         kHz           GN Response Time         Continuous GN Fault         350         ms           Internal Oscillator Frequency $F_{AC} = 60$ Hz ±0.1         1.8         2         2.2	LED Output Voltage	LED to GND, SUP < 4 V	3		3.6	V
Fault Response Time $6 \text{ mA} \le I_{DIFF} < 10 \text{ mA}$ 125msFault Response Time $10 \text{ mA} \le I_{DIFF} < 15 \text{ mA}$ 95msFault Response Time $15 \text{ mA} \le I_{DIFF} < 20 \text{ mA}$ 600msFault Response Time $17.5 \text{ mA} \le I_{DIFF} < 20 \text{ mA}$ 600msFault Response Time $20 \text{ mA} \le I_{DIFF} < 20 \text{ mA}$ 600msFault Response Time $20 \text{ mA} \le I_{DIFF} < 22.5 \text{ mA}$ 400msFault Response Time $22.5 \text{ mA} \le I_{DIFF} < 29 \text{ mA}$ 400msFault Response Time $29 \text{ mA} \le I_{DIFF} < 33 \text{ mA}$ 250msFault Response Time $29 \text{ mA} \le I_{DIFF} < 33 \text{ mA}$ 200msFault Response Time $10_{DIFF} > 33 \text{ mA}$ 200msCTG Comparator ThresholdCTG to GND, VDA = $3.3 V$ 1.95VCTG TimerCTG to GND, VDA = $3.3 V$ 1.95 $400$ $\mu a$ Internal Oscillator Frequency $F_{AC} = 60 \text{ Hz} \pm 0.1$ 1.822.2MLD Pair DetectVAc to GND, R7 = $1 \text{ MQ}, \pm 1\%$ 8008795VrmsMLD Pair Down CurrentMLD Pair NMAX Sink Current400 $\mu A$ MLD Pair NAX Sink Current400 $\mu A$ MLD Pair Down CurrentMLD Pair ST TimerVDA > $3 V$ $1.7$ $2$ $2.3$ secondPeriodic ST Timer, PassSteady State, ST Pass $15$ $17$ $20$ minuteLED Blink FrequencyFirst ST Failure $1.8$ $2$ $2.2$ $Hz$ LED Blink Frequency <td< td=""><td>CTB Bias Voltage</td><td>CTB to GND, VDA = 3.3 V</td><td></td><td>1.65</td><td></td><td>V</td></td<>	CTB Bias Voltage	CTB to GND, VDA = 3.3 V		1.65		V
Fault Response Time         10 mA $\leq l_{DIFF} < 15 \text{ mA}$ 95         ms           Fault Response Time         15 mA $\leq l_{DIFF} < 17.5 \text{ mA}$ 75         ms           Fault Response Time         17.5 mA $\leq l_{DIFF} < 20 \text{ mA}$ 60         ms           Fault Response Time         20 mA $\leq l_{DIFF} < 20 \text{ mA}$ 60         ms           Fault Response Time         20 mA $\leq l_{DIFF} < 20 \text{ mA}$ 40         ms           Fault Response Time         22.5 mA $\leq l_{DIFF} < 29 \text{ mA}$ 40         ms           Fault Response Time         28.5 mA $\leq l_{DIFF} < 29 \text{ mA}$ 25         ms           Fault Response Time         29 mA $\leq l_{DIFF} < 33 \text{ mA}$ 20         ms           Fault Response Time         0/IFF $\geq 33 \text{ mA}$ 20         ms           CTG Comparator Threshold         CTG to GND, VDA = 3.3 V         1.95         V           CTG finer         CTG to GND, VDA = 3.3 V         1.95         V         V           CTG GN Trip Frequency         CTG to GND         2         7         KHz           GN Response Time         Continuous GN Fault         350         ms           Internal Oscillator Frequency $F_{AC} = 60 \text{ Hz} \pm 0.1$ 1.8         2         2.2         MHz	CTS-CTB Absolute Offset Voltage	CTS-CTB	-250		250	μV
Fault Response Time $15 \text{ mA} \leq I_{DIFF} < 17.5 \text{ mA}$ 75msFault Response Time $17.5 \text{ mA} \leq I_{DIFF} < 20 \text{ mA}$ 600msFault Response Time $20 \text{ mA} \leq I_{DIFF} < 22.5 \text{ mA}$ 50msFault Response Time $22.5 \text{ mA} \leq I_{DIFF} < 22.5 \text{ mA}$ 40msFault Response Time $22.5 \text{ mA} \leq I_{DIFF} < 29 \text{ mA}$ 35msFault Response Time $20 \text{ mA} \leq I_{DIFF} < 29 \text{ mA}$ 20msFault Response Time $29 \text{ mA} \leq I_{DIFF} < 33 \text{ mA}$ 20msFault Response Time $I_{DIFF} \geq 33 \text{ mA}$ 20msCTG Comparator ThresholdCTG to GND, VDA = $3.3 \text{ V}$ 1.95VCTG GinmerCTG to GND, VDA = $3.3 \text{ V}$ 1.95VCTG GN Trip FrequencyCTG to GND27kHzGN Response TimeContinuous GN Fault350msInternal Oscillator Frequency $F_{AC} = 60 \text{ Hz} \pm 0.1$ 1.822.2MHzUnder Voltage DetectVA <sub>C</sub> to GND, R7 = 1 MΩ, $\pm 1\%$ 808795VrmsMLD Pul Down CurrentMLD = 1 V500nAFirst ST TimerVDA > 3 V1.722.3secondPeriodic ST Timer, PassSteady State, ST Pass151720minuteLED Blink FrequencyFirst ST Failure1.822.2HzLED Blink FrequencyNo MLD signal500msMinuteLED Blink FrequencyNo MLD signal1.522.5Hz	Fault Response Time	6 mA ≤ I <sub>DIFF</sub> < 10 mA			125	ms
Fault Response Time17.5 mA $\leq I_{DIFF} < 20$ mA60msFault Response Time20 mA $\leq I_{DIFF} < 22.5$ mA50msFault Response Time22.5 mA $\leq I_{DIFF} < 26.5$ mA40msFault Response Time26.5 mA $\leq I_{DIFF} < 29$ mA50msFault Response Time29 mA $\leq I_{DIFF} < 29$ mA50msFault Response Time29 mA $\leq I_{DIFF} < 33$ mA25msFault Response Time29 mA $\leq I_{DIFF} < 33$ mA20msCTG Comparator ThresholdCTG to GND, VDA = 3.3 V1.95VCTG TimerCTG > Threshold45 $\mu$ sCTG GN Trip FrequencyCTG to GND27kHzGN Response TimeContinuous GN Fault350msInternal Oscillator Frequency $F_{AC} = 60$ Hz ±0.11.822.2MHzUnder Voltage DetectV <sub>AC</sub> to GND, R7 = 1 MQ, ±1%808795VrmsMLD Pull Down CurrentMLD = 1 V500nAfirst ST TimerVDA > 3 V1.722.3secondPeriodic ST Timer, PassSteady State, ST Pass151720minuteLED Blink FrequencyFirst ST Failure1.822.2HzST Cycle GP Pass WindowI_DIFF Ground Fault614mAMLD Pin Continuity PassInput Frequency25HzHzLED Blink FrequencyNo MLD signal1.522.5Hz	Fault Response Time	10 mA ≤ I <sub>DIFF</sub> < 15 mA			95	ms
Fault Response Time $20 \text{ mA} \le I_{DIFF} < 22.5 \text{ mA}$ 50msFault Response Time $22.5 \text{ mA} \le I_{DIFF} < 26.5 \text{ mA}$ 40msFault Response Time $26.5 \text{ mA} \le I_{DIFF} < 29 \text{ mA}$ 35msFault Response Time $29 \text{ mA} \le I_{DIFF} < 33 \text{ mA}$ 25msFault Response Time $29 \text{ mA} \le I_{DIFF} < 33 \text{ mA}$ 20msFault Response Time $10 \text{ IFF} \ge 33 \text{ mA}$ 20msCTG Comparator ThresholdCTG to GND, VDA = 3.3 V1.95VCTG TimerCTG > Threshold45 $\mu$ sCTG GN Trip FrequencyCTG to GND27KHzGN Response TimeContinuous GN Fault350msInternal Oscillator Frequency $F_{AC} = 60 \text{ Hz} \pm 0.1$ 1.822.2MLD Aux Clamp Current $I_{MLD} Max Sink Current$ 400 $\mu A$ MLD Pull Down CurrentMLD = 1 V500nAFirst ST TimerVDA > 3 V1.722.3secondPeriodic ST Timer, PassSteady State, ST Pass151720minuteLED Blink FrequencyFirst ST Failure1.822.2HzMLD Pin Check Wait Time to Enable LEDNo MLD signal500msmsMLD Pin Continuity PassInput Frequency25HzHzLED Blink FrequencyNo MLD signal1.522.5Hz	Fault Response Time	15 mA ≤ I <sub>DIFF</sub> < 17.5 mA			75	ms
Fault Response Time $22.5 \text{ mA} \le I_{DIFF} < 26.5 \text{ mA}$ Image: Margin and	Fault Response Time	17.5 mA ≤ I <sub>DIFF</sub> < 20 mA			60	ms
Fault Response Time $26.5 \text{ mA} \le l_{DIFF} < 29 \text{ mA}$ $35$ msFault Response Time $29 \text{ mA} \le l_{DIFF} < 33 \text{ mA}$ $25$ msFault Response Time $l_{DIFF} \ge 33 \text{ mA}$ $20$ msCTG Comparator ThresholdCTG to GND, VDA = $3.3 \text{ V}$ $1.95$ $V$ CTG TimerCTG > Threshold $45$ $\mu$ sCTG GN Trip FrequencyCTG to GND $2$ $7$ $kHz$ GN Response TimeContinuous GN Fault $350$ msInternal Oscillator Frequency $F_{AC} = 60 \text{ Hz} \pm 0.1$ $1.8$ $2$ $2.2$ MHzUnder Voltage Detect $V_{AC}$ to GND, R7 = 1 MΩ, $\pm 1\%$ $80$ $87$ $95$ $V$ rmsMLD Max Clamp Current $I_{MLD} Max Sink Current$ $400$ $\mu$ AFirst ST TimerVDA > $3 V$ $1.7$ $2$ $2.3$ secondPeriodic ST Timer, PassSteady State, ST Pass $15$ $17$ $20$ minuteLED Blink FrequencyFirst ST Failure $1.8$ $2$ $2.2$ $Hz$ ST Cycle GF Pass Window $I_{DIFF}$ Ground Fault $6$ $14$ $mA$ MLD Pin Check Wait Time to Enable LEDNo MLD signal $500$ msMLD Pin Continuity PassInput Frequency $25$ $Hz$ LED Blink FrequencyNo MLD signal $1.5$ $2$ $2.5$ $Hz$	Fault Response Time	$20 \text{ mA} \le I_{\text{DIFF}} < 22.5 \text{ mA}$			50	ms
Fault Response Time $29 \text{ mA} \leq 1_{DIFF} < 33 \text{ mA}$ $25$ msFault Response Time $I_{DIFF} \geq 33 \text{ mA}$ $20$ msCTG Comparator ThresholdCTG to GND, VDA = $3.3 \text{ V}$ $1.95$ $V$ CTG TimerCTG > Threshold $45$ $\mu$ sCTG GN Trip FrequencyCTG to GND $2$ $7$ $kHz$ GN Response TimeContinuous GN Fault $350$ msInternal Oscillator Frequency $F_{AC} = 60 \text{ Hz} \pm 0.1$ $1.8$ $2$ $2.2$ $MHz$ Under Voltage Detect $V_{AC}$ to GND, R7 = $1 \text{ M}\Omega$ , $\pm 1\%$ $80$ $87$ $95$ $Vrms$ MLD Max Clamp Current $MLD$ $MLD = 1 \text{ V}$ $500$ $nA$ First ST Timer $VDA > 3 \text{ V}$ $1.7$ $2$ $2.3$ secondPeriodic ST Timer, PassSteady State, ST Pass $15$ $17$ $20$ minuteLED Blink FrequencyFirst ST Failure $1.8$ $2$ $2.2$ $Hz$ ST Cycle GF Pass Window $I_{DIFF}$ Ground Fault $6$ $14$ $mA$ MLD Pin Check Wait Time to Enable LEDNo MLD signal $500$ $ms$ MLD Pin Continuity Pass $Input Frequency$ $25$ $-14$ $Hz$ LED Blink FrequencyNo MLD signal $1.5$ $2$ $2.5$ $Hz$	Fault Response Time	22.5 mA $\leq I_{DIFF} < 26.5$ mA			40	ms
Fault Response Time $I_{DIFF} \ge 33 \text{ mA}$ 20msCTG Comparator ThresholdCTG to GND, VDA = 3.3 V1.95VCTG TimerCTG > Threshold45 $\mu$ sCTG GN Trip FrequencyCTG to GND27GN Response TimeContinuous GN Fault350msInternal Oscillator Frequency $F_{AC} = 60 \text{ Hz} \pm 0.1$ 1.822.2Under Voltage Detect $V_{AC}$ to GND, R7 = 1 MΩ, ±1%808795VrmsMLD Max Clamp Current $I_{MLD}$ Max Sink Current400 $\mu$ AMLD Pull Down CurrentMLD = 1 V500nAFirst ST TimerVDA > 3 V1.722.3secondPeriodic ST Timer, PassSteady State, ST Pass151720minuteLED Blink FrequencyFirst ST Failure1.822.2HzMLD Pin Check Wait Time to Enable LEDNo MLD signal500msmsMLD Pin Continuity PassInput Frequency25HzHzLED Blink FrequencyNo MLD signal1.522.5Hz	Fault Response Time	26.5 mA ≤ I <sub>DIFF</sub> < 29 mA			35	ms
CTG Comparator ThresholdCTG to GND, VDA = $3.3$ V1.95VCTG TimerCTG > Threshold45 $\mu$ sCTG GN Trip FrequencyCTG to GND27GN Response TimeContinuous GN Fault350msInternal Oscillator Frequency $F_{AC} = 60$ Hz $\pm 0.1$ 1.822.2Under Voltage Detect $V_{AC}$ to GND, R7 = 1 MQ, $\pm 1\%$ 808795VrmsMLD Max Clamp Current $I_{MLD}$ Max Sink Current400 $\mu$ AMLD Pull Down CurrentMLD = 1 V500nAFirst ST TimerVDA > 3 V1.722.3secondPeriodic ST Timer, PassSteady State, ST Pass151720minuteLED Blink FrequencyFirst ST Failure1.822.2HzMLD Pin Check Wait Time to Enable LEDNo MLD signal500msMLD Pin Continuity PassInput Frequency25HzLED Blink FrequencyNo MLD signal1.522.5Hz	Fault Response Time	29 mA ≤ I <sub>DIFF</sub> < 33 mA			25	ms
CTG TimerCTG > Threshold45 $\mu$ sCTG GN Trip FrequencyCTG to GND27kHzGN Response TimeContinuous GN Fault350msInternal Oscillator Frequency $F_{AC} = 60$ Hz $\pm 0.1$ 1.822.2MHzUnder Voltage Detect $V_{AC}$ to GND, R7 = 1 M $\Omega$ , $\pm 1\%$ 808795VrmsMLD Max Clamp Current $I_{MLD}$ Max Sink Current400 $\mu$ AMLD Pull Down CurrentMLD = 1 V500nAFirst ST TimerVDA > 3 V1.722.3secondPeriodic ST Timer, PassSteady State, ST Pass151720minuterLED Blink FrequencyFirst ST Failure1.822.2HzMLD Pin Check Wait Time to Enable LEDNo MLD signal500msmsMLD Pin Continuity PassInput Frequency25LHzLED Blink FrequencyNo MLD signal1.522.5Hz	Fault Response Time	I <sub>DIFF</sub> ≥ 33 mA			20	ms
CTG GN Trip FrequencyCTG to GND27kHzGN Response TimeContinuous GN Fault350msInternal Oscillator Frequency $F_{AC} = 60$ Hz $\pm 0.1$ 1.822.2MHzUnder Voltage Detect $V_{AC}$ to GND, R7 = 1 M $\Omega$ , $\pm 1\%$ 808795VrmsMLD Max Clamp Current $I_{MLD}$ Max Sink Current400 $\mu A$ MLD Pull Down Current $MLD = 1$ V500nAFirst ST TimerVDA > 3 V1.722.3secondPeriodic ST Timer, PassSteady State, ST Pass151720minutesLED Blink FrequencyFirst ST Failure1.822.2HzMLD Pin Continuity PassInput Frequency25msHzLED Blink FrequencyNo MLD signal1.522.5Hz	CTG Comparator Threshold	CTG to GND, VDA = 3.3 V		1.95		V
GN Response TimeContinuous GN Fault350msInternal Oscillator Frequency $F_{AC} = 60 \text{ Hz} \pm 0.1$ 1.822.2MHzUnder Voltage Detect $V_{AC}$ to GND, R7 = 1 MQ, ±1%808795VrmsMLD Max Clamp Current $I_{MLD}$ Max Sink Current400 $\mu A$ MLD Pull Down CurrentMLD = 1 V500nAFirst ST TimerVDA > 3 V1.722.3secondPeriodic ST Timer, PassSteady State, ST Pass151720minutesLED Blink FrequencyFirst ST Failure1.822.2HzMLD Pin Check Wait Time to Enable LEDNo MLD signal500msmsMLD Pin Continuity PassInput Frequency25LHzLED Blink FrequencyNo MLD signal1.522.5Hz	CTG Timer	CTG > Threshold		45		μs
Internal Oscillator Frequency $F_{AC} = 60 \text{ Hz} \pm 0.1$ 1.822.2MHzUnder Voltage Detect $V_{AC}$ to GND, R7 = 1 M $\Omega$ , $\pm 1\%$ 808795VrmsMLD Max Clamp Current $I_{MLD}$ Max Sink Current400 $\mu A$ MLD Pull Down CurrentMLD = 1 V500nAFirst ST TimerVDA > 3 V1.722.3secondPeriodic ST Timer, PassSteady State, ST Pass151720minuterLED Blink FrequencyFirst ST Failure1.822.2HzST Cycle GF Pass Window $I_{DIFF}$ Ground Fault614mAMLD Pin Continuity PassInput Frequency25-HzLED Blink FrequencyNo MLD signal1.522.5Hz	CTG GN Trip Frequency	CTG to GND	2		7	kHz
Under Voltage Detect $V_{AC}$ to GND, R7 = 1 M $\Omega$ , ±1%808795VrmsMLD Max Clamp CurrentII_MLD Max Sink Current400 $\mu$ AMLD Pull Down CurrentMLD = 1 V500nAFirst ST TimerVDA > 3 V1.722.3secondPeriodic ST Timer, PassSteady State, ST Pass151720minuterLED Blink FrequencyFirst ST Failure1.822.2HzST Cycle GF Pass WindowIDIFF Ground Fault614mAMLD Pin Continuity PassInput Frequency25HzLED Blink FrequencyNo MLD signal1.522.5Hz	GN Response Time	Continuous GN Fault			350	ms
MLD Max Clamp CurrentII400 $\mu$ AMLD Pull Down CurrentMLD = 1 V500nAFirst ST TimerVDA > 3 V1.722.3secondPeriodic ST Timer, PassSteady State, ST Pass151720minuterLED Blink FrequencyFirst ST Failure1.822.2HzST Cycle GF Pass WindowIDIFF Ground Fault614mAMLD Pin Check Wait Time to Enable LEDNo MLD signal500msMLD Pin Continuity PassInput Frequency25HzLED Blink FrequencyNo MLD signal1.522.5	Internal Oscillator Frequency	F <sub>AC</sub> = 60 Hz ±0.1	1.8	2	2.2	MHz
MLD Pull Down CurrentMLD = 1 V500nAFirst ST TimerVDA > 3 V1.722.3secondPeriodic ST Timer, PassSteady State, ST Pass151720minuterLED Blink FrequencyFirst ST Failure1.822.2HzST Cycle GF Pass WindowIDIFF Ground Fault614mAMLD Pin Check Wait Time to Enable LEDNo MLD signal500msMLD Pin Continuity PassInput Frequency25HzLED Blink FrequencyNo MLD signal1.522.5	Under Voltage Detect	$V_{AC}$ to GND, R7 = 1 M $\Omega$ , ±1%	80	87	95	Vrms
First ST TimerVDA > 3 V1.722.3secondPeriodic ST Timer, PassSteady State, ST Pass151720minuterLED Blink FrequencyFirst ST Failure1.822.2HzST Cycle GF Pass WindowIDIFF Ground Fault614mAMLD Pin Check Wait Time to Enable LEDNo MLD signal500msMLD Pin Continuity PassInput Frequency25HzLED Blink FrequencyNo MLD signal1.522.5	MLD Max Clamp Current	I <sub>MLD</sub> Max Sink Current			400	μA
Periodic ST Timer, PassSteady State, ST Pass151720minuterLED Blink FrequencyFirst ST Failure1.822.2HzST Cycle GF Pass WindowIDIFF Ground Fault614mAMLD Pin Check Wait Time to Enable LEDNo MLD signal500ImsMLD Pin Continuity PassInput Frequency25HzLED Blink Frequency251.52.5Hz	MLD Pull Down Current	MLD = 1 V		500		nA
LED Blink FrequencyFirst ST Failure1.822.2HzST Cycle GF Pass WindowIDIFF Ground Fault614mAMLD Pin Check Wait Time to Enable LEDNo MLD signal500msMLD Pin Continuity PassInput Frequency25HzLED Blink FrequencyNo MLD signal1.522.5	First ST Timer	VDA > 3 V	1.7	2	2.3	seconds
ST Cycle GF Pass WindowIDIFF Ground Fault614mAMLD Pin Check Wait Time to Enable LEDNo MLD signal500msMLD Pin Continuity PassInput Frequency25HzLED Blink FrequencyNo MLD signal1.522.5	Periodic ST Timer, Pass	Steady State, ST Pass	15	17	20	minutes
MLD Pin Check Wait Time to Enable LEDNo MLD signal500msMLD Pin Continuity PassInput Frequency25HzLED Blink FrequencyNo MLD signal1.522.5	LED Blink Frequency	First ST Failure	1.8	2	2.2	Hz
MLD Pin Continuity PassInput Frequency25HzLED Blink FrequencyNo MLD signal1.522.5Hz	ST Cycle GF Pass Window	I <sub>DIFF</sub> Ground Fault	6		14	mA
LED Blink Frequency No MLD signal 1.5 2 2.5 Hz	MLD Pin Check Wait Time to Enable LED	No MLD signal		500		ms
	MLD Pin Continuity Pass	Input Frequency	25	1		Hz
MLD Pin Check Wait Time to Enable SCR No MLD signal 6 minutes	LED Blink Frequency	No MLD signal	1.5	2	2.5	Hz
	MLD Pin Check Wait Time to Enable SCR	No MLD signal		6		minutes

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability. 8. Refer to ELECTRICAL CHARACTERISTICS and APPLICATION INFORMATION for Safe Operating Area.

#### **APPLICATIONS INFORMATION**



Note: A practical design for a portable GFCI application can be changed based on the requirements of a latching mechanism of a switch.

Figure 2. Portable GFCI Application Diagram (example)

#### Table 5. RECOMMENDED EXTERNAL COMPONENTS

Component Type	Instance	Value	Note
NPN	Q1A, Q1B, Q2	-	MMBT6517LT1-D
Diode Bridge	DB	-	
Diode	D2, D4	_	1N4007
LED	D3	_	LED for self test failure
Capacitor	C1	33 nF	Differential current filter capacitor
Capacitor	C2	56 nF	Anti-aliasing filter (1 kHz corner frequency)
Capacitor	C3	10 μF	Solenoid firming capacitor
Capacitor	C4	1 μF	SUP pin holding capacitor
Capacitor	C5	22–220 pF	Ground Neutral CT resonance capacitor
Capacitor	C6	4.7–47 nF	Ground Neutral CT AC coupler
Capacitor	C7	1 nF	CTB bias filter
Capacitor	C8	1 μF	Analog 3.3 V regulator filter
Capacitor	C9	1 nF	High frequency filter
Capacitor	C10	0.1–1 nF	High frequency filter for zero cross
Resistor	R1	243 Ω	Precision resistor (1%) differential low pass filter
Resistor	R2	-	Sets a resistance to create 8 mA fault current
Resistor	R3	10 kΩ	Sets the current in the base of Q2
Resistor	R4	6.8 kΩ	Limits current to the LED D3
Resistor	R5	20–47 kΩ	Sets base current in Q1A
Resistor	R6	72 kΩ	Power supply current limit
Resistor	R7	1 MΩ	MLD current limit/under voltage attenuator
Resistor	R8	32 kΩ	Precision resistor (1%) for differential trip level
Resistor	R9A, R9B	3.3–15 kΩ	Diode bridge short current limit
Resistor	R10	10–20 kΩ	Differential filter resistor
Resistor	R11	120 kΩ	Precision resistor (1%), Current reference bias resistor
Resistor	R12	10 kΩ	Test button pull-up resistor
Resistor	R13	47 kΩ	Q1B base pull-down resistor
Resistor	R14	20–47 kΩ	Sets base current in Q1B
Resistor	R15	22 kΩ	Reset button pull-down resistor
Resistor	Rcto	0.47–1.5 kΩ	Precision resistor (1%), Sets the differential trip level at 5 $mA_{RMS}$
Resistor	Rctg	$0-200 \ \Omega$	Sets the GN sensitivity
Current Transformer	CT1	800	Differential current transformer
Current Transformer	CT2	250	GN current transformer

#### Functional Description (refer to application circuit)

The NCS37015 provides for a single IC controller solution for ground fault, grounded neutral and self-test protection per UL standard UL943 for GFCI applications.

The key internal blocks include: 12 V shuft regulator, precision bandgap reference, two 3.3 V linear regulators (one for the digital and one for the analog circuit) sense amplifier with  $V_{OS}$  cancellation, 1.65 V reference for the CT, 2 MHz oscillator dynamically trimmed to the AC line frequency, 8 bit SAR ADC, comparators, digital filters and digital control logic.

To work more easily with portable GFCI applications the SCR pin will assert high on power–up. If a fault is detected or self–test fails the SCR pin will drive low and remain in this state until the part goes through a power on reset.

The internal shunt regulator clamps the SUP pin voltage at 12 volts. This provides the bias voltage for the analog (vda) and digital (vdd) internal circuitry via two 3.3 V linear regulators.

At POR detection (vda>2.475) the logic is reset and the bias circuitry is enabled, the LED pin will blink once for 250 ms. The MLD pin is continually checked for an input signal greater than 25 Hz. If the MLD signal is greater than 25 Hz, this test passes. If it fails, the LED blinking logic will be enabled. A six minute timer will start and if no MLD signal is detected, the SCR will be enabled. If a MLD signal occurs before the six minute timer and is longer than one minute, the timer will be reset.

The first self test (ST) cycle will occur at two seconds and thereafter every 17 minutes. During the ST cycle the GFT pin will be enabled and the CT current (set at 8 mA, R2) will be verified for two half cycles. If a ST cycle fails due to a low GF detection or a GF signal greater than 30 mA, the LED blinking logic will enable and the SCR pin will assert low.

The CT is biased at 1.65 volts. The sense amplifier monitors the ground fault current. This current is converted to a voltage level at the CTO pin which is the input to the ADC (IDF pin). The resistor R8 sets the GF threshold per the following equation:

$$I_{diff} = \frac{0.203 \times CT_1 \times \left(R_{CT1} + R_1 + 2\pi f_{AC}L_{CT1}\right)}{R_8 \times \left(R_{CT1} + 2\pi f_{AC}L_{CT1}\right)} \quad (eq. 1)$$

 $CT_1$  = Turns ratio of differential CT

 $R_{CT1}$  = DC winding resistance of differential CT

 $f_{AC}$  = AC mains frequency

L<sub>CT1</sub> = Inductance of differential CT

The ground fault detection circuit has different levels of time delay before the SCR is enabled:

6 mA to 10 mA	$\leq 125 \text{ ms}$
10  mA to  15  mA	$\leq 95 \text{ ms}$
15 mA to 17.5 mA	$\leq 75 \text{ ms}$
	_ /
17.5 mA to 20 mA	$\leq 60 \text{ ms}$
20 mA to 22.5 mA	$\leq 50 \text{ ms}$
22.5 mA to 26.5 mA	$\leq 40 \text{ ms}$

26.5 mA to 29 mA	$\leq$ 35 ms
29 mA to 33 mA	$\leq 25 \text{ ms}$
>33 mA	$\leq 20 \text{ ms}$

If a very high GF occurs and a greater than 200 mV signal occurs across the CT for greater than 1.4 ms, the SCR pin will be driven low immediately.

Note that the above equation is for an ideal CT. In practice, the GF threshold can be  $\pm 30\%$  different and should be empirically set.

When the PTT pin is enabled for greater than 64ms and if the GNE PIN is high (16ms when GNE PIN is low), a ST cycle will be enabled. If the ST cycle passes, the SCR pin will drive to 0V and the LED blinks once. If the ST cycle fails, the LED will enable to blink and the SCR pin will drive to 0 V.

The PTT pin has a 50 k $\Omega$  pull down resistor. This pin is a CMOS input with hysteresis. To enable the PTT function, the input voltage should go above 2.4 volts.

The MLD pin monitors the phase and zero cross for the AC supply. The MLD circuit clamps the pin voltage to gnd and vda. When the pin is clamped at vda, the current is compared to a threshold so if the VAC voltage is below 87  $V_{RMS}$ , the ST GF threshold will be reduced by 50%. This function provides for an AC under voltage detection which allows for the ST cycle to pass with a lower GF threshold. The AC UVD threshold can be user programmable by changing R7.

Grounded Neutral detection is accomplished by the addition of a GN coil to generate a "dormant oscillator" circuit. When a GN condition occurs, both the sense coil and GN coils are mutually coupled and the GN amplifier will oscillate. This oscillation can be observed at the CTG pin. When the oscillation at the CTG pin is above 1.95 volts for greater than 45 µs, and if this condition (oscillation) lasts for longer than 64 ms, the internal NCS37015 logic will disable the GN amplifier to stop the CTG oscillation for approximately 90 ms. The amplifier will be enabled again and if the oscillation on the CTG pin returns, the GN fault will be detected and the SCR will be enabled. This total sequence cycle takes a maximum of 175 ms. During power up, an additional maximum of 175 ms is required. The maximum time required during power up is 350 ms. The sensitivity of the GN detection can be changed by capacitor C6 and resistor Rctg. The frequency of this CTG oscillation needs to be in the 2 kHz to 7 kHz.

The internal oscillator is trimmed to 2 MHz when the AC frequency is 60 Hz. If the AC frequency is lower, the GF trip threshold response time will be slower and the GN sensitivity will be lower.

The RES pin will bias at 1.2 volts and should have an external precision 120 k $\Omega$  resistor connected to the GND pin. This resistor sets up an internal precision current source.

The TE pin is used for internal production testing only. A 50 k $\Omega$  pull down resistor is connected to this pin. This pin should be open or connected to the GND pin (preferred).

The GNE pin has an internal 50 k $\Omega$  pull up resistor connected to the internal 3.3 V supply. If this pin is pulled low, the GN function will be disabled.

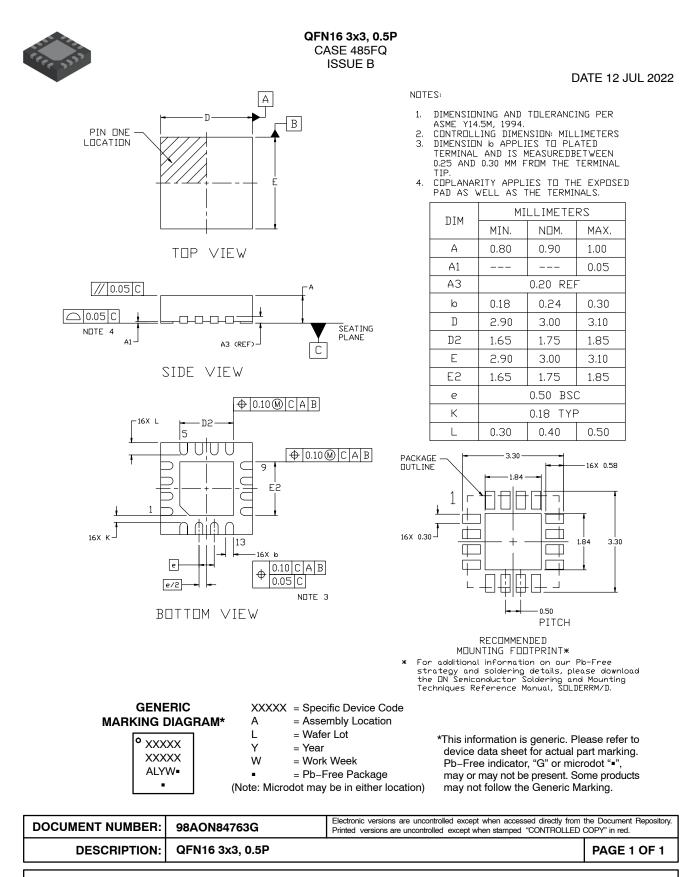
Contact ON Semiconductor for self-test requirement details and noise filtering recommendations.

#### **ORDERING INFORMATION**

Device	Package	Shipping †
NCS37015MNTWG	QFN16 (Pb-Free)	3000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# onsemi



onsemi and ONSEMI are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries. onsemi reserves the right to make changes without further notice to any products herein. onsemi makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. onsemi does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at <u>www.onsemi.com/site/pdf/Patent\_Marking.pdf</u>. onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or indental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification. Buyer shall indemnify and hold onsemi and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs,

#### ADDITIONAL INFORMATION

TECHNICAL PUBLICATIONS:

Technical Library: www.onsemi.com/design/resources/technical-documentation onsemi Website: www.onsemi.com

ONLINE SUPPORT: <u>www.onsemi.com/support</u> For additional information, please contact your local Sales Representative at <u>www.onsemi.com/support/sales</u>